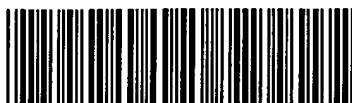


**Search Notes**

Application/Control No.

10/663,714

Examiner

A. Sefer

Applicant(s)/Patent under  
Reexamination

INOUE ET AL

Art Unit

2826

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search updated	5/29/2006	